


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580270	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEBE, HIROYUKI
	<b>Examiner</b>  Hsieh, Ping Y	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	129, 550.1, 562.1, 575.1, 575.3, 575.5, 575.7	1/16/08	PH
343	846, 848, 860, 702	1/16/08	PH

SEARCH NOTES		
Search Notes	Date	Examiner
Text search in EAST (see search history)	1/16/08	PH
PLUS search	1/16/08	PH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner